

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
215240US0PCTSERIAL NO.  
09/926,362

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Yasuji HIRAMATSU, et al.

FILING DATE

January 16, 2002

GROUP

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>YH</i>	AO	9-124383	05/13/97	JAPAN (submitting English Abstract only)		
<i>YH</i>	AP	8-236603	09/13/96	JAPAN (submitting English Abstract only)		
<i>YH</i>	AQ	5-97523	04/20/93	JAPAN (submitting English Abstract only)		
<i>YH</i>	AR	6-191955	07/12/94	JAPAN (submitting English Abstract only)		
<i>YH</i>	AS	11-111431	04/23/99	JAPAN (submitting English Abstract only)		
<i>YH</i>	AT	0 598 399	05/25/94	EUROPE		
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

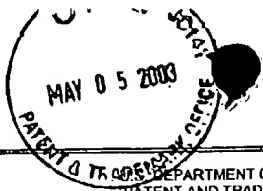
	AW					
	AX					
	AY					
	AZ					

Examiner

*YH*Date Considered *10/8/02*

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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1775

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	AA						
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
✓	AO	2-275765	11/09/90	JAPAN (with English translation)		
✓	AP	11-074064	03/16/99	JAPAN (with English translation)		
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW				
	AX				
	AY				
	AZ				

☐ Additional References sheet(s) attached

Examiner

Vivek Koppikar

Date Considered 5/5/03

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
21k	AH	2000-048262	04/15/2003	JAPAN (full text translation of the notification of the reasons for rejection, which is the basis of the priority right of IB369 US			1
21k	AI	JP9124383	05/13/1997	JAPAN (with English translation)			
21k	AJ	JP5117039	05/14/1993	JAPAN (with English translation)			
21k	AK	JP5147910	06/15/1993	JAPAN (with English translation)			
21k	AL	JP4317402	11/09/1992	JAPAN (with English translation)			
21k	AM	JP63011575	01/19/1988	JAPAN (with English translation)			
21k	AN	JP6191955	07/12/1994	JAPAN (with English translation)			
21k	AO	JP5097523	04/20/1993	JAPAN (with English translation)			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AP						
	AQ						
	AR						
	ASZ						
					<input type="checkbox"/> Additional References sheet(s) attached		
Examiner <i>mic Hagan</i>					Date Considered <i>1/21/2004</i>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							